Notice of References Cited

Application/Control No.	, ipplicallicati	nt Under		
09/759,257	SANO ET AL.	Reexamination SANO ET AL.		
Examiner	Art Unit			
Heather R Long	2615	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	. Classification
	Α	US-6,204,881	03-2001	Ikeda et al.	348/362
	В	US-6,141,047	10-2000	Kawai et al.	348/254
	С	US-2001/0001245	05-2001	Kamishima et al.	348/229
	D	US-5,194,960	03-1993	Ota, Yoshitaka	348/362
	Ε	US-5,455,621	10-1995	Morimura, Atsushi	348/229.1
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	W	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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